Searc	h Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/669,906	KAWAI ET AL.
Examiner	Art Unit
Phung T. Nguyen	2632

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	SEAR	CHED	
Class	Subclass	Date	Examiner
340	461	8/29/2005	PTN
	990		
	995.1		
	691.6		
345	156		
	685	8/29/2005	PTN

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
340	990	8/29/2005	PTN		
	995.1	, j			
345	156	8/29/2005	PTN		

(INCLUDIN	ARCH NOTES	RATEGY)
		DATE	EXMR
EAST	1	8/29/2005	PTN